Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/040,915	TEIG ET AL.	
Examiner	Art Unit	
A. M. Thompson	2825	

	SEAR	CHED	
Class	Subclass	Date	Examiner
716	12	1/1/2006	АМТ
716	13	1/1/2006	AMT
716	14	1/1/2006	AMT
716	15	1/1/2006	AMT

INTERFERENCE SEARCHED				
Subclass	Date	Examiner		
12	1/1/2006	AMT		
		-		
	Subclass	Subclass Date		

SEARCH NO (INCLUDING SEARCH	TES I STRATEGY)
	DATE	EXMR
USPAT; USPGPUB; DERWENT	1/1/2006	AMT